

July 1996

File Number

4091.1

## 6A, 1200V Hyperfast Dual Diode

The RHRP6120CC is a hyperfast dual diode with soft recovery characteristics (tRR < 55ns). It has half the recovery time of ultrafast diodes and is silicon nitride passivated ion-implanted epitaxial planar construction.

This device is intended for use as a freewheeling/clamping diode and rectifier in a variety of switching power supplies and other power switching applications. Its low stored charge and hyperfast soft recovery minimize ringing and electrical noise in many power switching circuits reducing power loss in the switching transistors.

Formerly developmental type TA49058.

### **PACKAGE AVAILABILITY**

PART NUMBER	PACKAGE	BRAND
RHRP6120CC	TO-220AB	RHR6120C

NOTE: When ordering, use the entire part number.

### **Features**

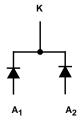
•	Hyperfast with Soft Recovery
•	Operating Temperature +175°C
•	Reverse Voltage1200\

- · Avalanche Energy Rated
- Planar Construction

### **Applications**

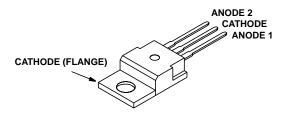
- Switching Power Supplies
- Power Switching Circuits
- General Purpose

## Symbol



### **Packaging**

#### **JEDEC TO-220AB**



### RHRP6120CC

## **Absolute Maximum Ratings** (Per Leg) $T_C = +25^{\circ}C$ , Unless Otherwise Specified

	RHRP6120CC	UNITS
Peak Repetitive Reverse VoltageV <sub>RRM</sub>	1200	V
Working Peak Reverse Voltage	1200	V
DC Blocking Voltage	1200	V
Average Rectified Forward Current $I_{F(AV)}$ $T_C = 130^{\circ}C$	6	Α
Repetitive Peak Surge CurrentI <sub>FSM</sub> Square Wave, 20kHz	12	Α
Nonrepetitive Peak Surge Current	60	Α
Maximum Power Dissipation	50	W
Avalanche Energy (See Figures 10 and 11)	10	mJ
Operating and Storage Temperature	-65 to +175	oC

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### **Electrical Specifications** (Per Leg) $T_C = +25^{\circ}C$ , Unless Otherwise Specified

SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNITS
V <sub>F</sub>	$I_F = 6A, T_C = +25^{\circ}C$	-	-	3.2	V
	$I_F = 6A, T_C = +150^{\circ}C$	-	-	2.6	V
I <sub>R</sub>	V <sub>R</sub> = 1200V, T <sub>C</sub> = +25°C	-	-	100	μΑ
	$V_R = 1200V, T_C = +150^{\circ}C$	-	-	500	μΑ
t <sub>RR</sub>	$I_F = 1A$ , $dI_F/dt = 200A/\mu s$	-	-	55	ns
	$I_F = 6A$ , $dI_F/dt = 200A/\mu s$	-	-	65	ns
t <sub>A</sub>	$I_F = 6A$ , $dI_F/dt = 200A/\mu s$	-	33	-	ns
t <sub>B</sub>	$I_F = 6A$ , $dI_F/dt = 200A/\mu s$	-	22	-	ns
Q <sub>RR</sub>	$I_F = 6A$ , $dI_F/dt = 200A/\mu s$	-	210	-	nC
СЈ	$V_{R} = 10V, I_{F} = 0A$	-	22	-	pF
$R_{ heta JC}$		-	-	3	°C/W

#### **DEFINITIONS**

 $V_F$  = Instantaneous forward voltage (pw = 300 $\mu$ s, D = 2%).

 $I_R$  = Instantaneous reverse current.

t<sub>RR</sub> = Reverse recovery time (See Figure 9), summation of t<sub>A</sub> + t<sub>B</sub>.

t<sub>A</sub> = Time to reach peak reverse current (See Figure 9).

 $t_B$  = Time from peak  $I_{RM}$  to projected zero crossing of  $I_{RM}$  based on a straight line from peak  $I_{RM}$  through 25% of  $I_{RM}$  (See Figure 9).

 $Q_{RR}$  = Reverse recovery charge.

 $C_J$  = Junction Capacitance.

 $R_{\theta JC}$  = Thermal resistance junction to case.

E<sub>AVL</sub> = Controlled Avalanche Energy (See Figures 10 and 11).

pw = pulse width.

D = duty cycle.

# **Typical Performance Curves**

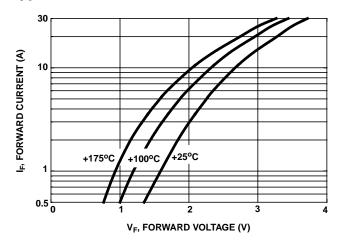


FIGURE 1. TYPICAL FORWARD CURRENT vs FORWARD VOLTAGE DROP

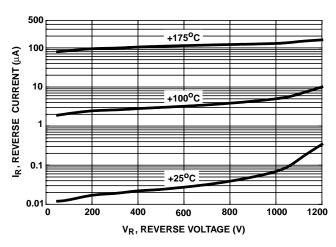


FIGURE 2. TYPICAL REVERSE CURRENT vs REVERSE VOLTAGE

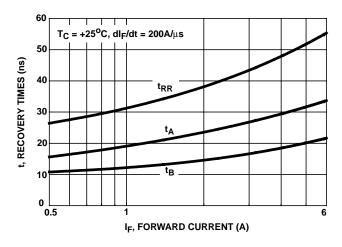


FIGURE 3. TYPICAL t<sub>RR</sub>, t<sub>A</sub> AND t<sub>B</sub> CURVES vs FORWARD CURRENT AT 25°C

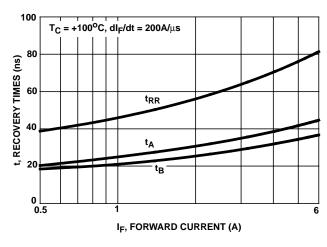


FIGURE 4. TYPICAL  $t_{RR}$ ,  $t_{A}$  AND  $t_{B}$  CURVES vs FORWARD CURRENT AT 100°C

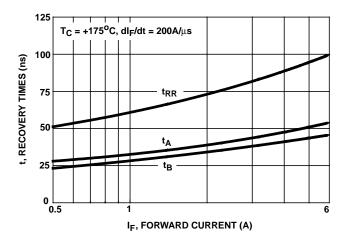


FIGURE 5. TYPICAL  $t_{RR}$ ,  $t_{A}$  AND  $t_{B}$  CURVES vs FORWARD CURRENT AT 175°C

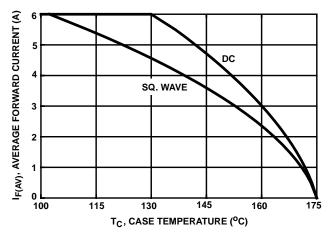


FIGURE 6. CURRENT DERATING CURVE

## Typical Performance Curves (Continued)

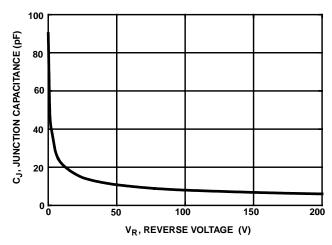


FIGURE 7. TYPICAL JUNCTION CAPACITANCE vs REVERSE VOLTAGE

# **Test Circuits and Waveforms**

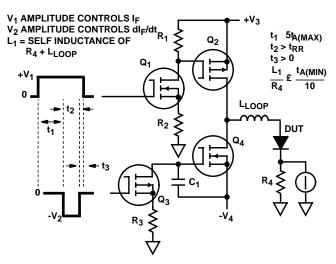


FIGURE 8. t<sub>RR</sub> TEST CIRCUIT

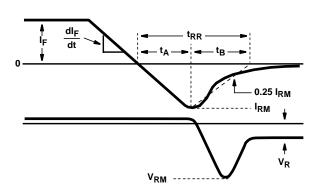


FIGURE 9. t<sub>RR</sub> WAVEFORMS AND DEFINITIONS

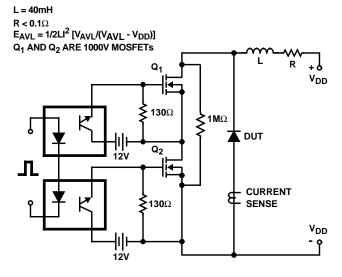


FIGURE 10. AVALANCHE ENERGY TEST CIRCUIT

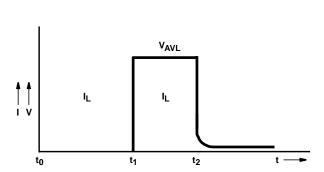
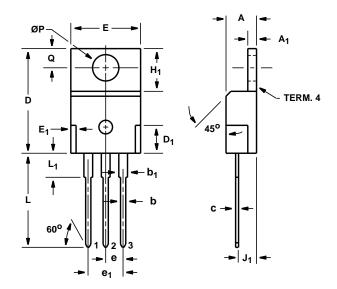


FIGURE 11. AVALANCHE CURRENT AND VOLTAGE WAVEFORMS

### TO-220AB

### **3 LEAD JEDEC TO-220AB PLASTIC PACKAGE**



LEAD 1. ANODE 1 LEAD 2. CATHODE LEAD 3. ANODE 2 TERM. 4. CATHODE

	INC	HES	MILLIMETERS		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	0.170	0.180	4.32	4.57	-
A <sub>1</sub>	0.048	0.052	1.22	1.32	-
b	0.030	0.034	0.77	0.86	3, 4
b <sub>1</sub>	0.045	0.055	1.15	1.39	2, 3
С	0.014	0.019	0.36	0.48	2, 3, 4
D	0.590	0.610	14.99	15.49	-
D <sub>1</sub>	-	0.160	-	4.06	-
E	0.395	0.410	10.04	10.41	-
E <sub>1</sub>	-	0.030	-	0.76	-
е	0.100 TYP		2.54 TYP		5
e <sub>1</sub>	0.200	BSC	5.08 BSC		5
H <sub>1</sub>	0.235	0.255	5.97	6.47	-
J <sub>1</sub>	0.100	0.110	2.54	2.79	6
L	0.530	0.550	13.47	13.97	-
L <sub>1</sub>	0.130	0.150	3.31	3.81	2
ØP	0.149	0.153	3.79	3.88	-
Q	0.102	0.112	2.60	2.84	-

#### NOTES:

- These dimensions are within allowable dimensions of Rev. J of JEDEC TO-220AB outline dated 3-24-87.
- 2. Lead dimension and finish uncontrolled in L<sub>1</sub>.
- 3. Lead dimension (without solder).
- 4. Add typically 0.002 inches (0.05mm) for solder coating.
- 5. Position of lead to be measured 0.250 inches (6.35mm) from bottom of dimension D.
- Position of lead to be measured 0.100 inches (2.54mm) from bottom of dimension D.
- 7. Controlling dimension: Inch.
- 8. Revision 1 dated 1-93.

All Intersil semiconductor products are manufactured, assembled and tested under ISO9000 quality systems certification.

Intersil semiconductor products are sold by description only. Intersil Corporation reserves the right to make changes in circuit design and/or specifications at any time without notice. Accordingly, the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

For information regarding Intersil Corporation and its products, see web site www.intersil.com

### Sales Office Headquarters

NORTH AMERICA

Intersil Corporation P. O. Box 883, Mail Stop 53-204 Melbourne, FL 32902

TEL: (321) 724-7000 FAX: (321) 724-7240 **EUROPE** 

Intersil SA Mercure Center 100, Rue de la Fusee 1130 Brussels, Belgium

TEL: (32) 2.724.2111 FAX: (32) 2.724.22.05 ASIA

Intersil (Taiwan) Ltd. 7F-6, No. 101 Fu Hsing North Road Taipei, Taiwan Republic of China

Republic of China TEL: (886) 2 2716 9310 FAX: (886) 2 2715 3029